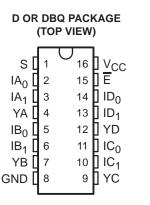
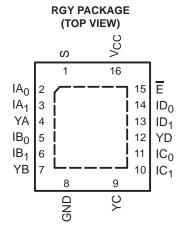
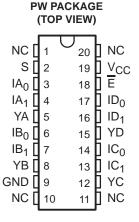
- Wide Bandwidth (BW = 300 MHz Min)
- Low Differential Crosstalk (X<sub>TALK</sub> = -60 dB Typ)
- Low Power Consumption (I<sub>CC</sub> = 3 μA Max)
- Bidirectional Data Flow, With Near-Zero Propagation Delay
- Low ON-State Resistance (r<sub>on</sub> = 3 Ω Typ)
- V<sub>CC</sub> Operating Range From 6 V to 6.5 V
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation

- Data and Control Inputs Provide Undershoot Clamp Diode
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)
- Suitable for Both 10 Base-T/100 Base-T Signaling







NC - No internal connection

#### description/ordering information

The TI TS5L100 LAN switch is a 4-bit 1-of-2 multiplexer/demultiplexer with a single switch-enable  $(\overline{E})$  input. When  $\overline{E}$  is low, the switch is enabled and the I port is connected to the Y port. When  $\overline{E}$  is high, the switch is disabled and the high-impedance state exists between the I and Y ports. The select (S) input controls the data path of the multiplexer/demultiplexer.

#### ORDERING INFORMATION

TA	PACKAG	et†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	QFN – RGY	Tape and reel	TS5L100RGYR	TG100
	0010 B	Tube	TS5L100D	T051 400
200 1- 7000	SOIC - D	Tape and reel	TS5L100DR	TS5L100
0°C to 70°C	SSOP (QSOP) – DBQ	Tape and reel	TS5L100DBQR	TG100
	TSSOP – PW	Tube	TS5L100PW	TC400
	1350P - PW	Tape and reel	TS5L100PWR	TG100

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



# TS5L100 QUAD SPDT WIDE-BANDWIDTH LAN SWITCH WITH LOW ON-STATE RESISTANCE

SCDS163A - MAY 2004 - REVISED MAY 2004

#### description/ordering information (continued)

This device can be used to replace mechanical relays in LAN applications. This device has low  $r_{on}$ , wide bandwidth, and low differential crosstalk, making it suitable for 10 Base-T, 100 Base-T, and various other LAN applications.

This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down,  $\overline{E}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

#### **FUNCTION TABLE**

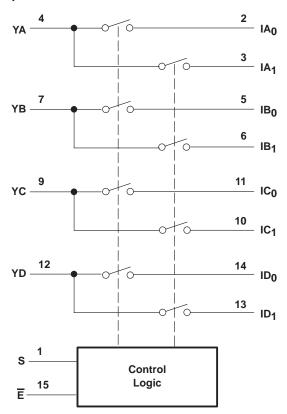
INP	JTS	INPUT/OUTPUT	FUNCTION				
Ē	S	YX	FUNCTION				
L	L	IX <sub>0</sub>	$YX = IX_0$				
L	Н	IX <sub>1</sub>	$YX = IX_1$				
Н	X	Z	Disconnect				

#### **PIN DESCRIPTIONS**

PIN NAME	DESCRIPTION
IAn–IDn	Data I/Os
S	Select input
Ē	Enable input
YA-YD	Data I/Os



# logic diagram (positive logic)





### TS5L100 QUAD SPDT WIDE-BANDWIDTH LAN SWITCH WITH LOW ON-STATE RESISTANCE

SCDS163A - MAY 2004 - REVISED MAY 2004

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Control input voltage range, V <sub>IN</sub> (see Notes 1 and 2)	
Switch I/O voltage range, V <sub>I/O</sub> (see Notes 1, 2, and 3)	$-0.5 \text{ V to 7 V}$
Control input clamp current, I <sub>IK</sub> (V <sub>IN</sub> < 0)	–50 mA
I/O port clamp current, $I_{I/OK}$ ( $V_{I/O}$ < 0)	–50 mA
ON-state switch current, I <sub>I/O</sub> (see Note 4)	±128 mA
Continuous current through V <sub>CC</sub> or GND terminals	$\dots \dots \pm 100 \ mA$
Package thermal impedance, $\theta_{JA}$ (see Note 5): D package	73°C/W
(see Note 5): DBQ package	90°C/W
(see Note 5): PW package	83°C/W
(see Note 6): RGY package	39°C/W
Storage temperature range, T <sub>sto</sub>	-65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltages are with respect to ground, unless otherwise specified.
  - 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
  - 3. V<sub>I</sub> and V<sub>O</sub> are used to denote specific conditions for V<sub>I/O</sub>.
  - 4. II and IO are used to denote specific conditions for II/O.
  - 5. The package thermal impedance is calculated in accordance with JESD 51-7.
  - 6. The package thermal impedance is calculated in accordance with JESD 51-5.

#### recommended operating conditions (see Note 7)

		MIN	MAX	UNIT
VCC	Supply voltage	6	6.5	V
VIH	High-level control input voltage $(\overline{\overline{E}}, S)$	2.5	6.5	V
V <sub>IL</sub>	Low-level control input voltage (E, S)	0	0.8	V
TA	Operating free-air temperature	0	70	°C

NOTE 7: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



# electrical characteristics over recommended operating free-air temperature range, $V_{CC} = 6 \text{ V}$ to 6.5 V (unless otherwise noted)

PARAMETER			TEST CONI	MIN	TYP <sup>†</sup>	MAX	UNIT	
VIK	Ē, S	V <sub>C</sub> C = 6 V,	$I_{IN} = -18 \text{ mA}$				-1.8	V
V <sub>hys</sub>	Ē, S					150		mV
Vo		V <sub>I</sub> = 4.5 V,	$\overline{E} = low,$	$R_L = 100 \Omega$ , see Figure 11	3.7	4.06		V
lн	Ē, S	V <sub>CC</sub> = 6.5 V,	VIN = VCC				±1	μΑ
Iμ	Ē, S	$V_{CC} = 6.5 V,$	V <sub>IN</sub> = GND				±1	μΑ
l <sub>OZ</sub> ‡		V <sub>CC</sub> = 6.5 V,	$V_O = 0 \text{ to } 6.5 \text{ V},$ $V_I = 0,$	Switch OFF			±1	μΑ
I <sub>OS</sub> §		V <sub>CC</sub> = 6.5 V,	$V_O = 0 \text{ to } 0.5 \text{ V}_{CC},$ $V_I = 0,$	Switch ON	50			mA
l <sub>off</sub>		$V_{CC} = 0$ ,	$V_0 = 0 \text{ to } 6.5 \text{ V},$	V <sub>I</sub> = 0			1	μΑ
Icc		$V_{CC} = 6.5 V,$	$I_{I/O} = 0$ ,	Switch ON or OFF			3	μΑ
ΔlCC	Ē, S	$V_{CC} = 6.5 V,$	One input at 3.4 V,	Other inputs at V <sub>CC</sub> or GND			6	mA
ICCD		V <sub>CC</sub> = 6.5 V,	I and Y ports open,	V <sub>IN</sub> input switching 50% duty cycle			0.35	mA/ MHz
C <sub>IN</sub>	Ē, S	f = 1 MHz				3.5		рF
0	I port	1,, 0	f = 1 MHz,	Cuitab OFF		4.5		
COFF	Y port	$V_{I} = 0,$	Outputs open,	Switch OFF		6.5		pF
CON		V <sub>I</sub> = 0,	f = 1 MHz, Outputs open,	Switch ON		14		pF
	M1	.,	0 11 1 011		7.5	11.2	19	
r <sub>on</sub>	on $M_2$ $V_1 = 4.5 \text{ V}$ , Switch		Switch ON,	h ON, $R_L = 100 \Omega$ , see Figure 11			6	Ω
$\Delta r_{on}$		V <sub>I</sub> = 4.5 V,	Switch ON			1	2	Ω

 $V_I,\,V_O,\,I_I,\,$  and  $I_O$  refer to I/O pins.  $V_{IN}$  refers to the control inputs.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 6 V to 6.5 V, $R_L$ = 100 $\Omega$ , $C_L$ = 35 pF (unless otherwise noted) (see Figure 7)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN MAX	UNIT
tON	S	Υ	7	ns
t <sub>OFF</sub>	S	Y	4	ns

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC}$  = 6.2 V (unless otherwise noted),  $T_A$  = 25°C.

# dynamic characteristics over recommended operating free-air temperature range, $V_{CC}$ = 6 V to 6.5 V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN TY	PT MAX	UNIT
X <sub>TALK</sub> (Diff)	$R_L = 100 \Omega$ , $f = 10 \text{ MHz}$ , see Figure 12, $t_\Gamma = t_f = 2 \text{ ns}$	-40 -	-60	dB
X <sub>TALK</sub>	$R_L = 100 \Omega$ , $f = 30 MHz$ , see Figure 9	-	-50	dB
O <sub>IRR</sub>	$R_L = 100 \Omega$ , $f = 30 MHz$ , see Figure 10	-	-40	dB
BW	$R_L$ = 100 Ω, see Figure 8		350	MHz

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 6.2 \text{ V}$  (unless otherwise noted),  $T_A = 25^{\circ}\text{C}$ .



<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC}$  = 6.2 V (unless otherwise noted),  $T_A$  = 25°C.

<sup>‡</sup> For I/O ports, I<sub>OZ</sub> includes the input leakage current.

<sup>§</sup> The IOS test is applicable to only one ON channel at a time. The duration of this test is less than one second.

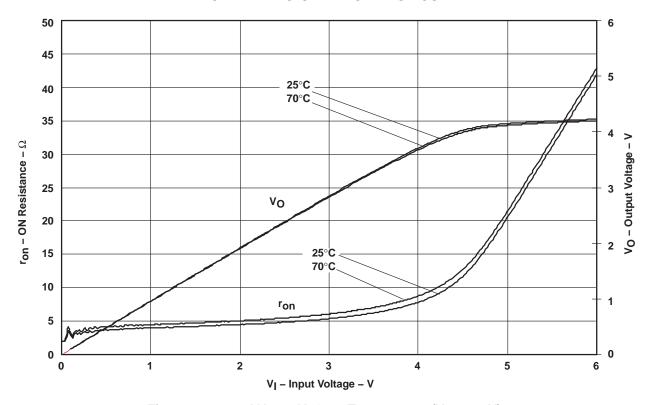


Figure 1.  $r_{on}$  and  $V_O$  vs  $V_I$  Over Temperature ( $V_{CC}$  = 6 V)



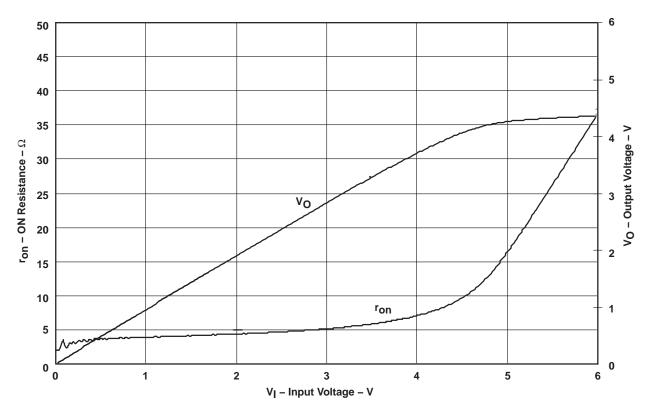
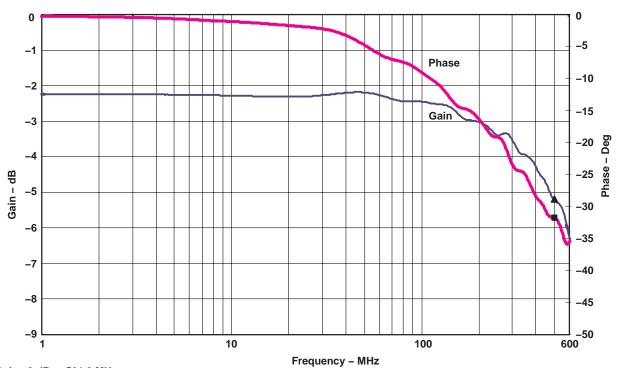


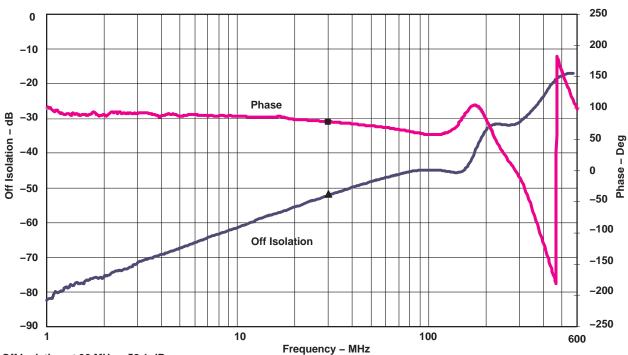
Figure 2.  $r_{on}$  and  $V_{O}$  vs  $V_{I}$  ( $V_{CC}$  = 6.2 V and  $T_{A}$  = 25°C)



- ▲ Gain -3 dB at 501.2 MHz
- Phase at -3-dB Frequency, -31.7 Degrees

Figure 3. Gain/Phase vs Frequency





- ▲ Off Isolation at 30 MHz, -52.1 dB
- Phase at 30 MHz, 77 Degrees

Figure 4. Off Isolation vs Frequency



- ▲ Crosstalk at 30 MHz, -54 dB
- Phase at 30 MHz, 93.2 Degrees

Figure 5. Crosstalk vs Frequency



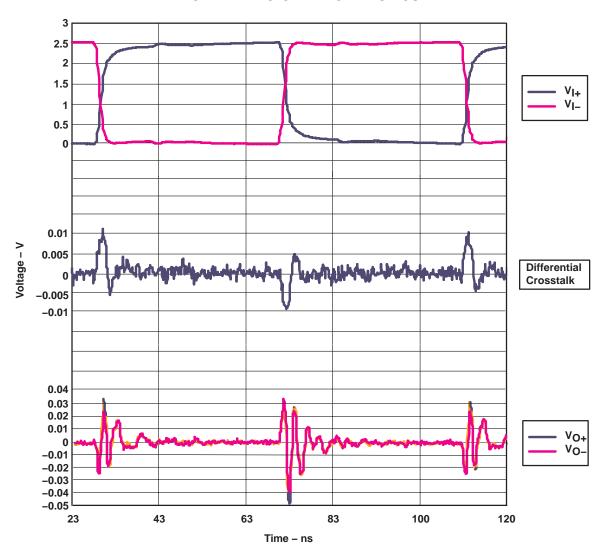
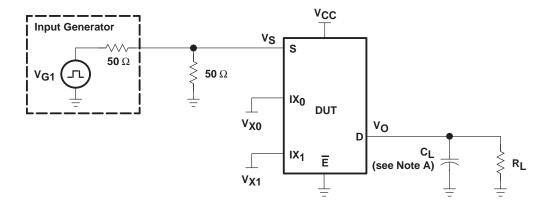


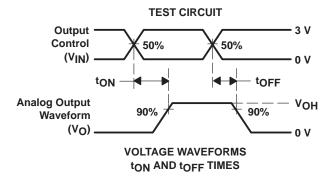
Figure 6. Differential Crosstalk



#### PARAMETER MEASUREMENT INFORMATION



TEST	VCC	RL	CL	V <sub>X0</sub>	V <sub>X1</sub>
ton	6.2 V	100 Ω	35 pF	GND	4.5 V
	6.2 V	100 Ω	35 pF	4.5 V	GND
tOFF	6.2 V	100 Ω	35 pF	GND	4.5 V
	6.2 V	100 Ω	35 pF	4.5 V	GND



- NOTES: A.  $C_L$  includes probe and jig capacitance. B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_f \leq$  2.5 ns.
  - C. The outputs are measured one at a time, with one transition per measurement.

Figure 7. Test Circuit and Voltage Waveforms

#### PARAMETER MEASUREMENT INFORMATION

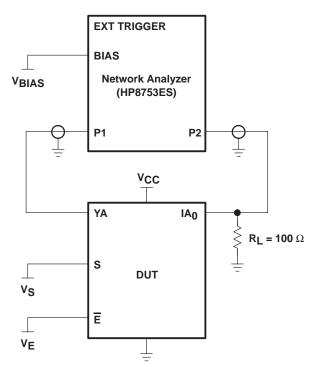


Figure 8. Test Circuit for Frequency Response (BW)

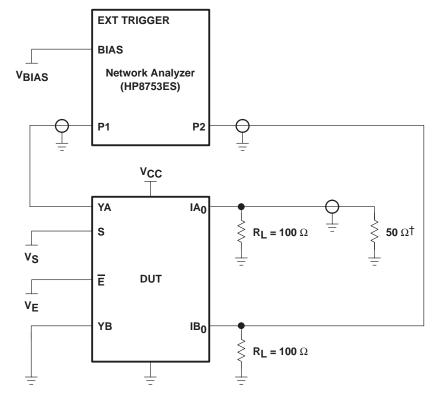
Frequency response is measured at the output of the ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at IA<sub>0</sub>. All unused analog I/O ports are left open.

#### HP8753ES setup

Average = 4 RBW = 3 kHz  $V_{BIAS} = 0.35 V$ ST = 2 s P1 = 0 dBM



#### PARAMETER MEASUREMENT INFORMATION



 $^{\dagger}$  A 50- $\!\Omega$  termination resistor is needed for the network analyzer.

Figure 9. Test Circuit for Crosstalk (X<sub>TALK</sub>)

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at IB<sub>0</sub>. All unused analog input (Y) ports are connected to GND, and output (A) ports are connected to GND through 50- $\Omega$  pulldown resistors.

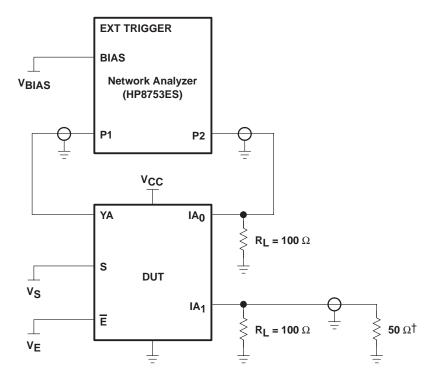
#### HP8753ES setup

Average = 4 RBW = 3 kHz  $V_{BIAS} = 0.35 V$ ST = 2 s

P1 = 0 dBM



#### PARAMETER MEASUREMENT INFORMATION



 $<sup>^{\</sup>dagger}$  A 50- $\!\Omega$  termination resistor is needed for the network analyzer.

Figure 10. Test Circuit for Off Isolation (OIRR)

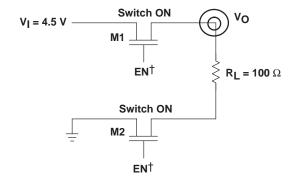
Off isolation is measured at the output of the OFF channel. For example, when  $V_S = V_{CC}$ ,  $V_E = 0$ , and YA is the input, the output is measured at IA<sub>0</sub>. All unused analog input (Y) ports are left open, and output (A) ports are connected to GND through  $50-\Omega$  pulldown resistors.

#### HP8753ES setup

Average = 4 RBW = 3 kHz  $V_{BIAS} = 0.35 V$ ST = 2 s P1 = 0 dBM



#### PARAMETER MEASUREMENT INFORMATION



†EN is the internal enable signal applied to the switch.

NOTE A:  $r_{ON}$  (M1) and  $r_{ON}$  (M2) are calculated from the voltage drop and current across the two terminals of M1 and M2, respectively.

Figure 11. Test Circuit for V<sub>O</sub> and r<sub>on</sub>

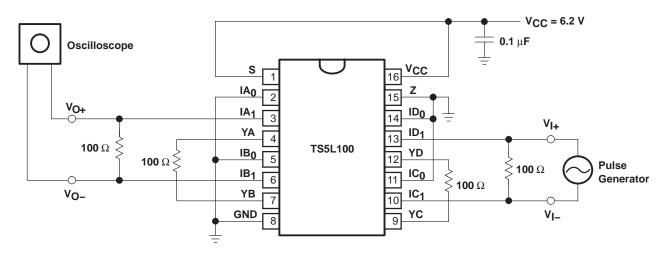


Figure 12. Differential Crosstalk Measurement

Differential crosstalk is a measure of coupling noise between a transmit and receive pair in the LAN application. Differential crosstalk depends on the edge rate, frequency, and load. This is calculated from the equation,  $X_{TALK}(Diff)$  db =  $20 \log V_O(Diff)/V_I(Diff)$ , where  $V_O(Diff)$  is the differential output voltage and  $V_I(Diff)$  is the differential input voltage.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
TS5L100D	Active	Production	SOIC (D)   16	40   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TS5L100
TS5L100D.A	Active	Production	SOIC (D)   16	40   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TS5L100
TS5L100DBQR	Active	Production	SSOP (DBQ)   16	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	TG100
TS5L100DBQR.A	Active	Production	SSOP (DBQ)   16	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	TG100
TS5L100DR	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TS5L100
TS5L100DR.A	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TS5L100
TS5L100PWR	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TG100
TS5L100PWR.A	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TG100

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

### **PACKAGE OPTION ADDENDUM**

www.ti.com 11-Nov-2025

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 25-Jul-2025

#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS5L100DBQR	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
TS5L100DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TS5L100PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1

**PACKAGE MATERIALS INFORMATION** 

www.ti.com 25-Jul-2025



#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins SPQ Length		Length (mm)	Width (mm)	Height (mm)
TS5L100DBQR	SSOP	DBQ	16	2500	353.0	353.0	32.0
TS5L100DR	SOIC	D	16	2500	340.5	336.1	32.0
TS5L100PWR	TSSOP	PW	20	2000	353.0	353.0	32.0

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 25-Jul-2025

#### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
TS5L100D	D	SOIC	16	40	507	8	3940	4.32
TS5L100D.A	D	SOIC	16	40	507	8	3940	4.32



SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# D (R-PDS0-G16)

#### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.





SHRINK SMALL-OUTLINE PACKAGE



#### NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
- 4. This dimension does not include interlead flash.5. Reference JEDEC registration MO-137, variation AB.



SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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